NSN 6625-00-222-1117

Semiconductor Device Test Set - Page 1 of 1



View Online at https://aerobasegroup.ae/nsn/6625-00-222-1117
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Shelf Life:
N/a
Unit Of Measure:
1 ea
Demilitarization:
No
Fiig:
T228-a Hazmat:
Yes
Repairability:
If condemned or uneconomically repairable then dispose at direct support (ds) level